Preparation and photoelectric properties of cadmium sulfide quantum dots

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Cadmium sulfide quantum dots (CdS QDs) are widely used in solar cells, light emitting diodes, photocatalysis and biological imaging because of their unique optical and electrical properties. However, there are some drawbacks in existing preparation techniques of CdS QDs, such as protection of inert gas, lengthy reaction time, high reaction temperature, poor crystallinity and non-uniform particle size distribution. In this study, we prepared CdS QDs by liquid phase synthesis under ambient room temperature and atmospheric pressure using sodium alkyl sulfonate, CdCl₂ and Na₂S as capping agent, cadmium and sulfur sources respectively. The technique offers facile preparation, efficient reaction, low-cost, and controllable particle size. The as-prepared CdS QDs exhibited good crystallinity, excellent monodispersity and uniform particle size. The responsivity of CdS QDs based photodetector was greater than 0.3 μA/W, which makes them suitable for use as UV detector.

Keywords: CdS QDs, liquid-phase synthesis, photoelectric properties

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1. Introduction

Semiconductor nanocrystals are referred as quantum dots (QDs), and their diameters are between 2 and 10 nm. The diameter is close to or less than the exciton Bohr radius resulting in the charge carrier to be confined in the nanometer regime. Due to the apparent quantum confinement effect, quantum dots have unique optical and electrical properties. They have great application prospects in optical absorption, photoluminescence and photoelectric conversion, and have been widely used in solar cells, light-emitting diodes (LEDs), photodetectors, photocatalysis and bioimaging. [1-10] The direct band gap of CdS QDs is 2.71 eV and can be used in photovoltaic solar cells, LEDs and displays etc. Many of these applications require the ability to control the size, shape, surface structure, size distribution, crystallinity and surface defects of the QDs. At present, there are several methods to prepare QDs, such as organic metal synthesis, template, hydrothermal, co-precipitation, sol-gel and wet chemical methods. [11-16] For example, Bach et al. [17] adopted co-precipitation method to obtain CdS QDs at room temperature after vacuum distillation for 12 h. Kumari et al. [18] synthesized CdSe QDs by continuously stirring for 5 h at high pH level of 11. Cao et al. [3] prepared CdSe QDs by using an improved organometallic synthesis method to dissolve sulfur powder and cadmium oxide in trioctylphosphine (TOP) at 240 °C. To date, most of the QDs preparation techniques were carried out under harsh conditions and often require lengthy reaction time and high synthesis temperature. Therefore, these techniques are unsuitable for volume production due to low yield and high cost. In this study, we demonstrated the synthesis of CdS QDs having wurtzite structure at ambient room temperature and atmospheric pressure by liquid phase synthesis. The as-prepared CdS QDs exhibited uniform diameter and good crystallinity. Compared with existing methods, this method offers many advantages such as facile preparation, low-cost and controllable QDs size. Furthermore, the preparation technique is suitable for volume production and can potentially be applied to synthesize other quantum dots. This study will make significant contributions to the development of CdS QDs based photodetectors.

2. Experiment

2.1. Chemicals and reagents

Na$_2$S, CdCl$_2$ and NaC$_{12}$H$_{25}$SO$_3$ were purchased from Tianjin Fengchuan Chemical Reagent Co. Ltd. (Tianjin, China), and the reagents were of analytical grade.

2.2. Fabrication of CdS QDs

Na$_2$S (10 mg/mL) and CdCl$_2$ (10 mg/mL) were mixed with an equal volume of colorless transparent sodium alkyl sulfonate (SDS) solution (0.03 mol/mL). Na$_2$S (950 μL) was added to 325 μL of CdCl$_2$ solution at 45 °C and allowed them to react for 10 min under room temperature and
atmospheric pressure. The supernatant was removed after centrifugation at 3000 rpm for 10 min, ethylene glycol and deionized water (at a ratio of 1:1) were then added. The mixed solution was sonicated for 20 min and centrifuged for a further 10 min. The supernatant was discarded and deionized water was added to the as-prepared yellow CdS QDs. Finally, the CdS QDs were dialyzed (300 MW) for 24 h prior to the fabrication of an ultraviolet (UV) photodetector.

2.3. Instrumentation
The morphology and size distribution of the CdS QDs were investigated using transmission electron microscopy (TEM, Tecnai G2F30-TWIN) with an operating voltage of 300 kV. UV-Vis absorption spectra were measured using a U-4100 spectrometer. The X-ray diffraction (XRD) patterns of the samples were acquired using Rigaku D/Max-23. The photoluminescence (PL) and PL excitation (PLE) spectra were measured using photoluminescence spectrometer (Hitachi F-7000). The surface morphology and roughness were studied by atomic force microscope (AFM, Bruker Dimension ICON). The cross-sectional view of the device was investigated by scanning electron microscope (SEM) (NOVA NANOSEM 450). Functional groups on the CdS QDs were studied using Fourier Transform infra-red spectroscopy (FTIR, Nicolet iS10). The Raman spectra were obtained using Renishaw inVia Raman microscope with a wavelength of 514.5 nm. The elemental composition of CdS QDs was investigated by x-ray photoelectron spectroscopy (XPS, PHI 5000 Versa Probe II). The images of the interdigital electrodes were observed using Leica optical microscope (DM 2700M). The current-voltage (I-V) curves were measured using a semiconductor device analyzer (Keysight B1500A).

3. Instrumentation
3.1. Structural and optical characterization
The schematic diagram on the preparation of CdS QDs is illustrated in Fig. 1(a). SDS was mixed with Na₂S and CdCl₂ solutions at room temperature and atmospheric pressure, and allowed them to react for 10 min. SDS was a surface passivator which prevented the QDs from aggregating and forming irregular morphologies. The CdS QDs were centrifugated, sonicated and then washed to purification. Fig. 1(b) shows the TEM image of the as-prepared CdS QDs revealing spherical shape with excellent dispersibility. HRTEM images of CdS QDs are shown in Figs. 1(c), 1(d) and 1(e). The measured lattice fringes are 0.196, 0.213 and 0.217 nm, which correspond to (103), (110) or (220) of the wurtzite structure respectively.\cite{19,20} The Fast Fourier Transform (FFT) patterns in the insets of Fig. 1(c) ~ 1(e) also suggest the wurtzite structure of CdS QDs. Fig. 1(f) shows the diameter distribution of CdS QDs as shown in Fig. 1(a). The size of CdS QDs followed a Gaussian fitted distribution ranging from 2 nm to 7.5 nm.
Fig. 1. (a) Illustration of the synthetic method to prepare CdS QDs, (b) TEM images of the CdS QDs, (c)–(e) HRTEM images of the CdS QDs, FFT pattern (inset) of single CdS QDs, (f) diameters distribution of the CdS QDs, (g) and (j) the SEM images of CdS QDs, (h) AFM image of the CdS QDs, four QDs are labelled as A, B, C and D, (i) size measurement of the four QDs in (h).

with an average diameter of 3.91 nm, the full width at half-maximum (FWHM) was 2.15 nm. SEM images of the CdS QDs are shown in Fig. 1(g) and Fig. 1(j) which show QDs can be uniformly assembled in the form of thin solid film. However, agglomeration and accumulation of the QDs were also observed. Four random CdS QDs (marked as A, B, C, D) were identified from the AFM image as shown in Fig. 1(h). The height of these four CdS QDs is measured as 1.6 nm, 2.6 nm, 8.1 nm, and 3.9 nm with an average size of 4.1 nm. It is consistent with the average diameter of 3.91 nm obtained from the size distribution graph in Fig. 1(f).

The particle size was estimated from the band gap value using Brus equation by effective mass approximation (EMA).\cite{21-23}

\[
E_{np} = E_g + \frac{\hbar^2 \pi^2}{2R^2} \left( \frac{1}{m_e} + \frac{1}{m_h} \right) - \frac{1.8\sigma^2}{4\pi\varepsilon R},
\]  (1)
Here, $E_{np}$ is the bandgap of the CdS QDs, $E_g$ is the band gap constant, $e$ is the electron charge, $m_e^*$ is the effective mass of electron (0.19$m_e$ in CdS), $m_h^*$ is the effective mass of hole (0.8$m_e$ in CdS), $R$ is the radius of the particle, $\varepsilon$ is the dielectric constant (5.7). The calculated $E_{np}$ values are 2.84 eV ($R=2.01$ nm) and 3.21 eV ($R=1.96$ nm), which are bigger than the bulk value (2.42 eV) due to the quantum effect.

The properties of the as-prepared CdS QDs were studied using XRD, Raman and FTIR techniques as shown in Figs. 2(a), 2(c) and 2(e) respectively. Fig. 2(a) shows the diffraction peaks at $2\theta = 34.36^\circ$, $40.42^\circ$ and $52.74^\circ$ of the CdS QDs, which can be readily assigned to the (0 0 2), (2 2 0) and (3 1 1) planes of the wurtzite structure respectively. These peaks were comparatively wider than those of the bulk materials due to the finite crystalline size. This is in agreement with the HRTEM results. Si and SiO$_2$ peaks, marked by asterisk (*), were also observed in the XRD spectrum due to the presence of SiO$_2$ at the surface of the silicon substrate, which the test sample was deposited for...
Fig. 3. (a) The full-scan XPS spectrum of the CdS QDs, (b) the Cd\textsubscript{3d3} and Cd\textsubscript{3d5} XPS spectra, (c) the S\textsubscript{2p} XPS spectrum.

colorization. Fig. 2(c) shows the Raman spectrum of the CdS QDs, where the basic optical phonon mode (LO) of CdS is situated at 307 cm\textsuperscript{-1}.\cite{26} The FTIR spectrum of the CdS QDs is presented in Fig. 2(e). There are two significant stretching of vibration absorption peaks at 723.83 cm\textsuperscript{-1} and 1619.98 cm\textsuperscript{-1} due to Cd-S bonds. The absorption peaks at 1067.93 cm\textsuperscript{-1} and 1196.66 cm\textsuperscript{-1} are related to S-O. The peaks at 802.75 cm\textsuperscript{-1}, 2852.32 cm\textsuperscript{-1}, 2922.71 cm\textsuperscript{-1} and 3345.83 cm\textsuperscript{-1} are corresponded to C-O-S, -CH\textsubscript{2}, -CH\textsubscript{2} and -OH, respectively.\cite{27, 28} The UV-Vis, PL and PLE spectra are presented in Fig. 2(b), 2(d) and 2(f), respectively. Fig. 2(b) shows an absorption peak at 422 nm for the CdS QDs. This demonstrated a blue shift, when compared to the absorption peak of 520 nm for CdS bulk material. Such phenomenon is attributed to quantum confinement effect at the CdS QDs. Fig. 2(d) shows the PL spectra when the excitation wavelength varies from 275 nm to 325 nm at an interval of 25 nm, the emission peaks centered at ~ 455 nm. The PLE spectra of the as-prepared
CdS QDs are as shown in Fig. 2(f). The position of the peaks was obviously red-shifted as the emission wavelength increases, which may be due to the difference in QDs size.

In order to confirm the elemental composition of the CdS QDs, XPS measurement was performed. Fig. 3(a) shows a full-scan XPS spectrum of the CdS QDs. It clearly shows the existence of cadmium and sulfur in the as-prepared materials. The main peaks are S2p peak (167.2 eV), C1s peak (284.8 eV), Cd3d3 peak (404 eV), Cd3d5 peak (411.2 eV) and O1s peak (532 eV). The deconvoluted peaks of the two spin-orbit peaks of Cd, namely Cd3d3 and Cd3d5, are shown in Fig. 3(b), which consisted of 412.46 eV (Cd-S), 411.86 eV (Cd-O), 405.66 eV (Cd-S) and 405.26 eV (Cd-O). The appearance of Cd-O may be due to the surface oxidation of CdS QDs in the air. S2p peak is fitted with three peaks as shown in Fig. 3(c), which comprised of 161.66 eV (S-Cd), 162.66 eV (S-Cd) and 168.26 eV (S-C). The presence of S-C is due to the residual surfactant SDS in the sample. Therefore, the XPS analysis demonstrated the existence of Cd-S bonds in the as-prepared QDs and this is consistent with the findings from XRD, Raman, and FTIR studies.

3.2. Optoelectronic properties

According to the UV-Vis spectrum of the CdS QDs, a strong absorption of light is observed at wavelength less than 500 nm and hence an UV detector based on the CdS QDs was fabricated. Fig. 4(a) illustrates the fabrication processes of the CdS QDs photodetectors using interdigital gold electrodes as previously reported. The CdS QDs solution was dialyzed (300 MW) for 24 h at room temperature and then drop-cast onto the interdigitated electrodes. This was followed by drying at 70°C for 20 min. Fig. 4(d) shows the determination of the optical band gap using UV-Vis spectroscopy. Since CdS is a direct band gap material, the optical band gap can be expressed by Eqns. (2) and (3)

\[ \alpha h \nu = B (h \nu - E_g)^2, \]  
\[ A = abc, \]

where \( \alpha \) is the molar absorption coefficient, \( h \) is Planck constant, \( \nu \) is the incident photon frequency, \( B \) is a proportional constant, \( A \) is the sample absorbance, \( b \) is the sample width, and \( c \) is the sample concentration. Based on the calculation, the optical band gap of CdS QDs is \( E_g = 2.71 \) eV. The result is close to \( E_{np} = 2.84 \) eV calculated by Eqn. (1). The \( I-V \) curve of the UV photodetector irradiated under dark and light conditions (fluorescent lamp, optical power density: 114.3 mW/cm²) is shown in Fig. 4(e). Under the light condition, the photocurrent increased when compared to that from the dark condition. The responsivity \( R \) of the photodetector can be expressed by Eqn. (4)

\[ R = J_{ph}/P_{opt}, \]

where \( J_{ph} \) is the photocurrent density and \( P_{opt} \) is the optical power density. The responsivity of CdS
4. Conclusion

In this study, CdS QDs with narrow size distribution, good crystallinity and excellent dispersibility were prepared using liquid-phase synthesis at room temperature and pressure. The CdS QDs has an optical band gap of 2.71 eV. They were spherical in shape with an average particle size of 3.91 nm. Furthermore, UV-Vis, PL and PLE studies showed that CdS QDs exhibited strong absorption of light at wavelength less than 500 nm. Photodetector based on CdS QDs was fabricated to measure the photocurrent under dark and light conditions. The responsivity of such device was found to be greater than 0.3 μA/W under light illumination. The simple preparation method is suitable for volume production of the QDs, and has major significance in the research and application of CdS QDs ultraviolet detector.

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